## **ON Semiconductor®**



Title of Change:	Update Typical Reading of Tr and Tf in Datasheet for 40V T6 products.
Effective date:	11 May 2017
Contact information:	Contact your local ON Semiconductor Sales Office or <guokun.yeng@onsemi.com></guokun.yeng@onsemi.com>
Type of notification:	ON Semiconductor will consider this change accepted.
Change category:	Wafer Fab Change Assembly Change Test Change Other Datasheet
Change Sub-Category(s): Manufacturing Site Change Manufacturing Process Cha	
Sites Affected:	pplicable ON Semiconductor site(s) : External Foundry/Subcon site(s) ON Seremban, Malaysia
Description and Purpose:	
This Product Bulletin is announcing that ON Semiconductor is updating datasheet for below products. The change is to update typical reading of switching parameter, <b>Tr</b> and <b>Tf</b> to reflect the actual device performance. ON is improving the measurement method with reduce influence of parasitic inductance in the measurement PCB design.	
List of Affected Standard Parts:	
NTMFS5C423NLT1G NTMFS5C423NLT3G NTMFS5C442NLT1G NTMFS5C442NLT3G NTMFS5C442NLTT1G NTMFS5C442NLTWFT1G NTMFS5C442NLTWFT1G NTMFS5C442NLTWFT3G NTMFS5C460NLT1G NTMFS5C460NLT3G	